

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

NAKAYA ET AL.

Examiner

MICHAEL E. NELSON

Art Unit

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Page 1 of 1

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W	Machine Translation of JP 2002-256168 (9/2002).
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
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